

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/721,823	ZHAO ET AL.	
	<b>Examiner</b> Hien D. Vu	<b>Art Unit</b> 2833	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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